

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	3116	29/592.1,595,603.08.603.18,852, 885.ccls.	USPAT; JPO; DERWENT	OR	ON	2005/10/31 08:00
L2	15	sonic\$4 near (etch\$3 or ablat\$3)	USPAT; JPO; DERWENT	OR	ON	2005/10/31 08:11
L3	3	(sonic\$4 near (etch\$3 or ablat\$3)) with (insulat\$3 or dielect\$3)	USPAT; JPO; DERWENT	OR	ON	2005/10/31 08:48
L4	5	("4762594" "4963245" "5120421" "5403451" "5635054").PN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/10/31 08:05
L5	7	("5635054").URPN.	USPAT	OR	ON	2005/10/31 08:07
L6	23	("3854193" "3855099" "3904487" "3914509" "4003705" "4062750" "4090926" "4115209" "4214968" "4233031" "4450842" "4545382" "4661210" "4695555" "4786373" "4804443" "4865992" "5019515" "5120421" "5131999" "5192416" "5290420" "5292423").PN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/10/31 08:07
L7	401	\$5sonic\$4 near (etch\$3 or ablat\$3)	USPAT; JPO; DERWENT	OR	ON	2005/10/31 08:12
L8	17	(\$5sonic\$4 near (etch\$3 or ablat\$3)) with (hole or pore)	USPAT; JPO; DERWENT	OR	ON	2005/10/31 08:12
L9	8139	(fill\$3 or apply\$3 or form\$3) near (metal or conduct\$3) near (hole or pore or via)	USPAT; JPO; DERWENT	OR	ON	2005/10/31 08:28
L10	2	7 and 9	USPAT; JPO; DERWENT	OR	ON	2005/10/31 08:13
L11	40	sensor with ((fill\$3 or apply\$3 or form\$3) near (metal or conduct\$3) near (hole or pore or via))	USPAT; JPO; DERWENT	OR	ON	2005/10/31 08:16
L12	2345	measur\$3 near analyte	USPAT; JPO; DERWENT	OR	ON	2005/10/31 08:17
L13	178	measur\$3 near analyte with solution	USPAT; JPO; DERWENT	OR	ON	2005/10/31 08:24
L14	51	measur\$3 near analyte near solution	USPAT; JPO; DERWENT	OR	ON	2005/10/31 08:23

L15	1	sensor near measur\$3 near analyte near solution	USPAT; JPO; DERWENT	OR	ON	2005/10/31 08:18
L16	2	sensor with (measur\$3 near analyte near solution)	USPAT; JPO; DERWENT	OR	ON	2005/10/31 08:20
L17	4	sensor same (measur\$3 near analyte near solution)	USPAT; JPO; DERWENT	OR	ON	2005/10/31 08:21
L18	0	9 and 13	USPAT; JPO; DERWENT	OR	ON	2005/10/31 08:21
L19	527	427/2.11-2.13.ccls.	USPAT; JPO; DERWENT	OR	ON	2005/10/31 08:21
L20	1758	204/400,403,406.ccls.	USPAT; JPO; DERWENT	OR	ON	2005/10/31 08:21
L21	2309	216/13,18.ccls.	USPAT; JPO; DERWENT	OR	ON	2005/10/31 08:21
L22	0	9 and 19	USPAT; JPO; DERWENT	OR	ON	2005/10/31 08:22
L23	5	9 and 20	USPAT; JPO; DERWENT	OR	ON	2005/10/31 08:22
L24	5	sensor near analyte near solution	USPAT; JPO; DERWENT	OR	ON	2005/10/31 08:23
L25	323	sensor with measur\$3 near analyte	USPAT; JPO; DERWENT	OR	ON	2005/10/31 08:24
L26	323	sensor with (measur\$3 near analyte)	USPAT; JPO; DERWENT	OR	ON	2005/10/31 08:25
L27	0	1 and 26	USPAT; JPO; DERWENT	OR	ON	2005/10/31 08:25
L28	2	9 and 26	USPAT; JPO; DERWENT	OR	ON	2005/10/31 08:25
L30	2	((fill\$3 or apply\$3 or form\$3) near (metal or conduct\$3) near (hole or pore or via)) same (array near electrode)	USPAT; JPO; DERWENT	OR	ON	2005/10/31 08:32
L31	6	treat\$3 near (metal or conduct\$3) near ((chemical near solution) or thiol)	USPAT; JPO; DERWENT	OR	ON	2005/10/31 08:34

L32	36271	sensor with sensitivity	USPAT; JPO; DERWENT	OR	ON	2005/10/31 08:49
L33	35	sensor with sensitivity with versatility	USPAT; JPO; DERWENT	OR	ON	2005/10/31 08:49
L34	1	sensor with sensitivity with versatility with metal	USPAT; JPO; DERWENT	OR	ON	2005/10/31 08:50
L35	0	sensitivity near versatility near metal	USPAT; JPO; DERWENT	OR	ON	2005/10/31 08:50
L36	5	sensitivity with versatility with metal	USPAT; JPO; DERWENT	OR	ON	2005/10/31 08:50
L37	0	salzer-corey-a.in.	USPAT; JPO; DERWENT	OR	ON	2005/10/31 09:25
L38	0	salzer-corey.in.	USPAT; JPO; DERWENT	OR	ON	2005/10/31 09:25
L39	0	salzer-corey.in.	US-PGPUB; USPAT; JPO; DERWENT	OR	ON	2005/10/31 09:25
L40	1	salzer-corey-a.in.	US-PGPUB; USPAT; JPO; DERWENT	OR	ON	2005/10/31 09:25



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» Key

IEEE JNL IEEE Journal or Magazine

IEE JNL IEE Journal or Magazine

IEEE CNF IEEE Conference Proceeding

IEE CNF IEE Conference Proceeding

IEEE STD IEEE Standard

1. **Laser micromachined high frequency ultrasonic arrays**

Lukacs, M.; Sayer, M.; Lockwood, G.; Foster, S.;
Ultrasonics Symposium, 1999. Proceedings. 1999 IEEE
Volume 2, 17-20 Oct. 1999 Page(s):1209 - 1212 vol.2
Digital Object Identifier 10.1109/ULTSYM.1999.849214

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